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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Application Number	10/555,663-Conf. #9919
		Filing Date	December 4, 2006
		First Named Inventor	Shigenori FUJIKAWA
		Art Unit	4191
		Examiner Name	B. A. Schiffman
Sheet	1	of	1
		Attorney Docket Number	1248-1030PUS1

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Examiner Initials*	Cite No.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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	BD	JP-10-249985-A	09-22-1998	Kunitake et al.		✓
Examiner Signature				Date Considered		

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NON PATENT LITERATURE DOCUMENTS			
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CA		H. FUJII et al., "Synthesis of TiO ₂ /CdS nanocomposite via TiO ₂ coating on CdS nanoparticles by compartmentalized hydrolysis of Ti alkoxide", Journal of Materials Science, Vol. 36, pp. 527-532 (2001)	
CB		B. E. YOLDAS, "Deposition and properties of optical oxide coatings from polymerized solutions", Applied Optics, Vol. 21, No. 16, pp. 2960-2964, August 15, 1982	

Examiner Signature	/Benjamin Schiffman/	Date Considered	11/19/2009
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